

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under

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Examiner

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Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,210,291	04-2001	Kato et al.	473/357
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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